

SANYO Semiconductors DATA SHEET

N-Channel Silicon MOSFET

ECH8621R — General-Purpose Switching Device Applications

Features

- · Low ON-resistance.
- · Best suited for lithium battery applications.
- · 2.5V drive.
- · Composite type, facilitating high-density mounting.
- · Drain common specifications.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		20	V
Gate-to-Source Voltage	VGSS		±12	V
Drain Current (DC)	ΙD		8	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	40	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (900mm ² X0.8mm) 1unit	1.4	W
Total Dissipation	PT	Mounted on a ceramic board (900mm²X0.8mm)	1.5	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Uill
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0V	20			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =20V, V _{GS} =0V			1	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} =±8V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	VGS(off)	V _{DS} =10V, I _D =1mA	0.5		1.3	V
Forward Transfer Admittance	yfs	V _{DS} =10V, I _D =4A	6.6	11		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	I _D =4A, V _G S=4.5V	11	15.5	20	mΩ
	RDS(on)2	ID=4A, VGS=4.0V	11.2	16	21	mΩ
	R _{DS} (on)3	I _D =4A, V _{GS} =3.1V	12	18.5	24	mΩ
	R _{DS} (on)4	I _D =2A, V _G S=2.5V	13.2	22	30	mΩ
Input Capacitance	Ciss	V _{DS} =10V, f=1MHz		1250		pF
Output Capacitance	Coss	V _{DS} =10V, f=1MHz		240		pF
Reverse Transfer Capacitance	Crss	V _{DS} =10V, f=1MHz		210		pF

Marking: WF Continued on next page.

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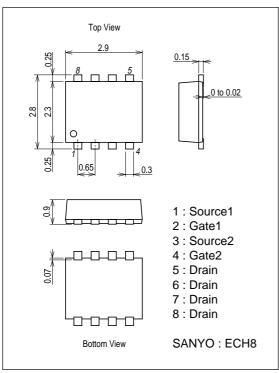
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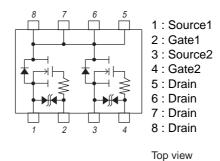
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Turn-ON Delay Time	td(on)	See specified Test Circuit.		544		ns
Rise Time	t _r	See specified Test Circuit.		2200		ns
Turn-OFF Delay Time	td(off)	See specified Test Circuit.		4400		ns
Fall Time	tf	See specified Test Circuit.		3700		ns
Total Gate Charge	Qg	V _{DS} =10V, V _{GS} =4.5V, I _D =8A		15		nC
Gate-to-Source Charge	Qgs	V _{DS} =10V, V _{GS} =4.5V, I _D =8A		2.5		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =10V, V _{GS} =4.5V, I _D =8A		5		nC
Diode Forward Voltage	V _{SD}	I _S =8A, V _{GS} =0V		0.85	1.2	V

Package Dimensions

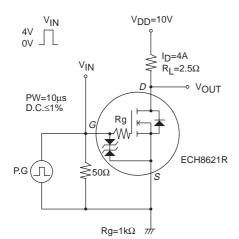
unit : mm 7011A-003

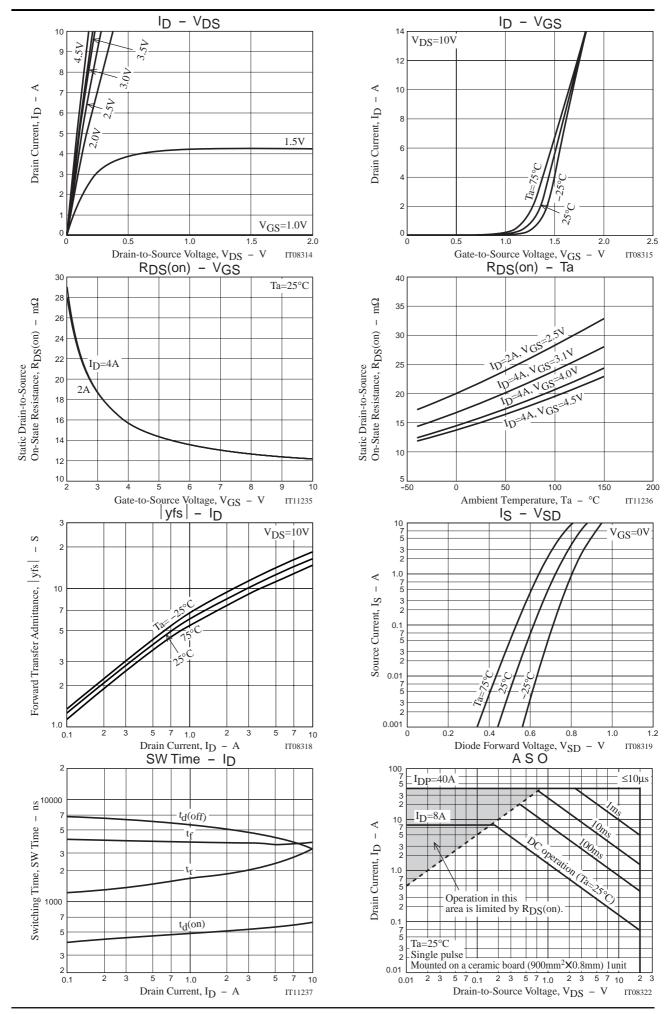


Electrical Connection

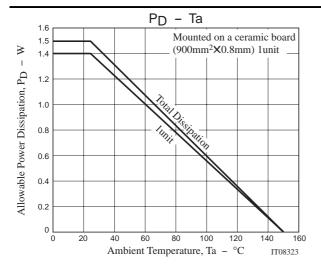


Switching Time Test Circuit





ECH8621R



Note on usage: Since the ECH8621R is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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